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200mA Dual Output AMOLED Display Power

Check for Samples: [TPS65137](http://www.ti.com/product/tps65137#samples)

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-
- **shutdown**
- **• 3×3 mm 10 Pin QFN Package**

APPLICATIONS

• Active Matrix OLED Power Supply

TYPICAL APPLICATION

¹FEATURES DESCRIPTION

The TPS65137 is designed to provide best in class **• 2.3 V to 5.5 V Input Voltage Range** picture quality for AMOLED displays (Active Matrix **• 1% Output Voltage Accuracy ^VPOS** Organic Light Emitting Diode) requiring positive and **• Excellent Line Transient Regulation** negative voltage supply rails. With its wide input voltage range the device is ideally suited for **• Low Noise Operation** AMOLED displays, which are used in mobile phones **100 mA Output Current**
 Fixed 4.63 V Positive Output Voltage
 Fixed 4.63 V Positive Output Voltage
 Positive Current and smart phones. With this device the input voltage
 Fixed 4.63 V Positive Output Voltage • Fixed 4.63 V Positive Output Voltage can be higher than the positive output voltage and **Pigitally Programmable Negative Output** still maintains accurate regulation of V_{POS}. Using the **Voltage Down to –5.23V** digital control pin (CTRL) allows adjusting the negative output voltage in digital steps. The **• –4.93V Default Value for ^VNEG** TPS65137 uses ^a novel technology enabling **• Advanced Power Save Mode** excellent line and load regulation with minimum **•• Short Circuit Protection** *••• Protection* output voltage ripple by using a LDO post regulator **Thermal Shutdown**
 •• for V_{POS}. This is required avoiding disturbance of the **Thermal Shutdown**
For VPOS. This is required avoiding disturbance of the **AMOLED** display due to input voltage transients
PS65137A High impedance output in
 AMOLED display due to input voltage transients *CO CO TRS65334* **Digital occurring during transmit periods in mobile phones.**

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or visit the device product folder on ti.com.

(2) Contact the factory for the availability of the TPS65137 with output voltage discharge function.

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted) $⁽¹⁾$ </sup>

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute–maximum–rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to network ground terminal.

THERMAL INFORMATION

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, [SPRA953](http://www.ti.com/lit/pdf/spra953).

(2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.

(3) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDECstandard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

(4) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.

(5) The junction-to-top characterization parameter, ψ_{JT} , estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ_{JA} , using a procedure described in JESD51-2a (sections 6 and 7).

(6) The junction-to-board characterization parameter, ψ_{JB} , estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining θ_{JA} , using a procedure described in JESD51-2a (sections 6 and 7).

(7) The junction-to-case (bottom) thermal resistance is obtained by simulating a cold plate test on the exposed (power) pad. No specific JEDEC standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

RECOMMENDED OPERATING CONDITIONS(1)

(1) Refer to application section for further information.

ELECTRICAL CHARACTERISTICS

 ${\sf V}_{\sf IN}=3.5{\sf V}$, EN = VIN, OUTP = 4.63V, OUTN = –4.93V, T $_{\sf A}$ = –40°C to 85°C, typical values are at T $_{\sf A}$ = 25°C (unless otherwise noted)

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DEVICE INFORMATION

Pin Functions

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NSTRUMENTS

Texas

TYPICAL CHARACTERISTICS TABLE OF GRAPHS

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 $(V_{IN} = 4.5V)$

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Figure 9. LINE TRANSIENT RESPONSE (150mA) Figure 10. LINE TRANSIENT RESPONSE (100mA)

20 µs/div

Figure 13. SHORT CIRCUIT

V NEG 2 V/div V POS 2 V/div

V IN 2 V/div Iin 100 mA/div

Iout 100 mA/div

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DETAILED DESCRIPTION

The TPS65137 consists of a boost converter using a LDO as post regulator. The output voltage of the boost converter is regulated to operate the internal LDO above its dropout voltage maintaining best line and load regulation of OUTP. The internal LDO disconnects OUTP during shutdown and allows regulation of the output when the input voltage is higher than OUTP. The LDO minimizes the output voltage ripple of OUTP. The negative output uses a buck boost converter topology operating in DCM (Discontinuous Conduction Mode) providing superior line regulation. In order to adjust the output voltage of the negative converter a digital interface can be used to program the output voltage. To achieve high efficiency over the entire load current range the device reduces the switching frequency with the load current using its internal voltage controlled oscillator (VCO). Since the boost converter output CB is post regulated by the integrated LDO (Low Dropout Regulator) the output voltage ripple is minimized and the line transient response is at its best. Because of this topology the operation mode of the boost converter has minimum effect on the output voltage ripple observed on OUTP. The boost converter, as well as the negative converter operate in peak current mode using the VCO (Voltage Controlled Oscillator) while operating in DCM (Discontinuous Conduction Mode). When entering CCM (Continuous Conduction Mode) the converter operates in peak current control using fixed off time control.

POWER SAVE MODE OPERATION

In order to maintain high efficiency over the entire load current range the converter reduces its switching frequency as the load current decreases. To maintain a controlled switching frequency a voltage controlled oscillator (VCO) is used.

SOFT START AND SHORT CIRCUIT PROTECTION

The device has a soft-start implemented limiting inrush current during turn on. The device is also protected against short circuits of the outputs to ground or when the outputs shorted together. This is implemented with two output voltage thresholds determining the device switch current limit and LDO operation shown in [Figure](#page-9-0) 14.

Figure 14. Soft Start and Short Circuit Thresholds

When the device is enabled pulling CTRL pin high then the boost converter and buck converter starts with reduced switch current limit. During this period of time the LDO is turned off. As V_{NFG} reaches –0.4V then the LDO is turned on having a 100mA current limit. The switch current limit of both outputs is increased to 220mA and 120mA. When V_{POS} reaches 3V and V_{NEG} reaches –1V, then both outputs operate with full current limit. This architecture limits the inrush current during start-up and protects the device during short circuits events. When the positive output is shorted to the negative output then the device cycles between the first and second section of the start-up sequence. By that, the output current cycles between zero and 100mA. This protects the device and avoids excessive power dissipation during short circuit conditions. With this architecture the device is able to start-into full load current once V_{POS} exceeds 3V and V_{NEG} is lower than –1V.

ENABLE (CTRL pin)

The CTRL pin serves two functions. One is the enable and disable of the device, the other is the output voltage programming of the device. If the digital interface is not required the CTRL pin can be used as a standard enable pin for the device. Pulling CTRL high starts the converter operating with its default output voltage on OUTN of –4.93V.

DIGITAL INTERFACE (CTRL)

The digital interface allows programming the negative output voltage OUTN in digital steps. If the digital output voltage setting is not required then the CTRL pin can also be used as a standard enable pin. In such a case the device will come up with its default output voltage of OUTN of –4.93V.

Figure 15. CTRL Used as a Standard Device Enable

The digital output voltage programming of OUTN is implemented by a simple digital interface with the timing shown in [Figure](#page-10-0) 16.

Once CTRL is pulled high the device will come up with its default voltage of –4.93V. The TPS65137 has a 5 bit DAC implemented with the correspondent output voltage as given in [Table](#page-11-0) 1. The interface counts the rising edges applied to CTRL pin once the device is enable. For example with the timing diagram shown in [Figure](#page-10-0) 16, OUTN is programmed to –4.93V since 4 rising edges are applied. Other output voltages are programmed according to [Table](#page-11-0) 1.

Vneg Programming Transition Time tset for OUTN (CT)

The TPS65137 allows setting the transition time t_{set} using an external capacitor connected to pin CT. The transition time is the time period required to move OUTN from one voltage level to the next programmed voltage level. When the CT pin is left open then the shortest possible transition time is programmed. When connecting a capacitor to the CT pin then the transition time is given by the R-C time constant. This is given by the output impedance of the CT pin of typically 250kΩ and the external capacitance. Within one *τ* the output voltage OUTN has reached 70% of its programmed value. An example is given when using 100nF for C_T .

 $\tau \approx t_{\text{set70\%}} = 250 \text{ k}\Omega \times C_T = 250 \text{ k}\Omega \times 100 \text{ nF} = 25 \text{ mS}$

INPUT CAPACITOR SELECTION

The device typically requires a 4.7μF ceramic input capacitor. Larger values can be used to lower the input voltage ripple.

Table 2. Input Capacitor Selection

BOOST CONVERTER DESIGN CONSIDERATION, Vpos

The positive output consists of a boost converter using a LDO as post regulator. The maximum output current is limited by the minimum current limit of the LDO, of 200mA. The component values and output current are calculated at maximum load current in continuous conduction operation. The typical switching frequency during this operation mode is 1.4MHz.

The boost converter duty cycle is:

$$
D = 1 - \frac{V_{\text{IN}} \times \eta}{V_{\text{POS}}}
$$

To calculate the duty cycle, a good estimation for the efficiency, η, is 75% or it can be taken out of the typical curve in **Figure 1**. In order to calculate the maximum output current of the boost converter for a certain input voltage, the following formula is used:

(1)

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[TPS65137](http://www.ti.com/product/tps65137?qgpn=tps65137)

(2)

$$
\underline{\text{www.ti.com}}
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$$
Iout = (1 - D) \bigg(Isw - \frac{V_{IN} \times D}{2 \times fs \times L} \bigg)
$$

The maximum output current is given at the highest switching frequency of typically 1.4MHz and minimum switch current limit of 0.9A. [Equation](#page-12-0) 3 is used to calculate the switch peak current.

$$
I_{\text{swpeak}} = \frac{V_{\text{IN}} \times D}{2 \times f s \times L} + \frac{I_{\text{out}}}{1 - D}
$$
\n(3)

The inductor needs to be rated for this switch peak current to avoid inductor saturation.

The boost converter output capacitor is connected to pin CB and a 4.7µF capacitor is sufficient. A 2.2µF capacitor is used on the output V_{POS} , which is the output of the internal low dropout regulator (LDO).

Table 3. Output Capacitor Selection

NEGATIVE BUCK BOOST CONVERTER DESIGN CONSIDERATION, Vneg

The negative output is generated with a buck boost converter. The component values and output current are calculated at maximum load current in continuous conduction operation. The typical switching frequency during this operation mode is 1.4MHz.

The buck boost converter duty cycle is:

$$
D = \frac{|V_{\text{NEG}}|}{V_{\text{IN}} \times \eta + |V_{\text{NEG}}|}
$$
\n(4)

To calculate the duty cycle a good estimation for the efficiency, η, is 75% or it can be taken out of the typical curve in Figure 1. In order to calculate the maximum output current of the buck boost converter for a certain input voltage, the following formula is used:

$$
Iout = (1 - D) \left(Isw - \frac{V_{N} \times D}{2 \times fs \times L} \right)
$$
\n(5)

The maximum output current is given at the highest switching frequency of typically 1.4MHz and minimum switch current limit of 1.1A. [Equation](#page-12-1) 6 is used to calculate the switch peak current.

$$
I_{\text{swpeak}} = \frac{V_{N} \times D}{2 \times f s \times L} + \frac{I_{\text{out}}}{1 - D}
$$
\n(6)

The inductor needs to be rated for this switch peak current to avoid inductor saturation. Refer to [Table](#page-12-2) 4 for possible inductors for this application. A 4.7 μ F output capacitor is used on the output V_{NEG}. Larger capacitor values can be used to minimize the output voltage ripple. Refer to [Table](#page-12-3) 3 for output capacitor selection.

INDUCTOR SELECTION

The device is optimized to operate with 4.7uH inductors. Different inductor values will change the converter efficiency and output voltage ripple. A 2.2uH inductor is also a possible solution. Any other inductor values will degrade device performance and stability which is not recommended for this device.

Table 4. Inductor Selection

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APPLICATION INFORMATION

PCB LAYOUT

The layout for his device is important to keep the output voltage ripple and output voltage accuracy as low and accurate as possible. The following layout guidelines apply for this device:

- Keep the switch note pad for the boost converter and inverter switch as small as possible to avoid coupling into the output.
- The ground connection for the inductor of the negative converter needs to be as wide as possible to avoid noise generated by inductor ground currents.
- The ground connection of the timing capacitor on pin CT needs to be isolated and directly routed to the GND pin of the device. This is important to avoid noise being coupled into the error amplifier which is internally connected to the CT pin.
- Having the ground connection of the boost converter output capacitor and LDO output capacitor in a close connection to the device ground and power pad connection achieves best load regulation.

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REVISION HISTORY

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PACKAGING INFORMATION

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check<http://www.ti.com/productcontent>for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

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PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

MECHANICAL DATA

The package thermal pad must be soldered to the board for thermal and mechanical performance.

 $\not\subset\setminus$ See the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.

DSC (S-PWSON-N10)

PLASTIC SMALL OUTLINE NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack D. Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <http://www.ti.com>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- $F.$ Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.

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